

**INDUSTRY STANDARD OF THE
PEOPLE'S REPUBLIC OF CHINA**

SJ/T 11577-2016

**SJ/T 11394-2009 semiconductor light-emitting diode test
method Application Guide**

SJ/T 11394-2009 半导体发光二极管测试方法应用指南
(English Translation)

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Table of Contents

What this standard covers	1
Document data	2

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This standard specifies the details that SJ/T11394-2009 "Semiconductor LED Test Method" standard should pay attention to during actual measurement and operation. The content of this standard can provide effective guidance for the measurement of LED light, color, electricity and other parameters, which can improve the accuracy and repeatability of measurement. This standard applies to visible light LED device products, other LED device products can refer to implementation.

Document data

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